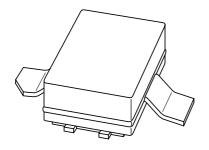
DISCRETE SEMICONDUCTORS

DATA SHEET



BLA1011-2Avionics LDMOS transistor

Product specification Supersedes data of 2002 Oct 02 2003 Nov 19





Avionics LDMOS transistor

BLA1011-2

FEATURES

- · High power gain
- · Easy power control
- Excellent ruggedness
- Source on mounting base eliminates DC isolators, reducing common mode inductance.

APPLICATIONS

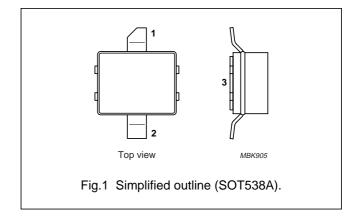
 Avionics applications in the 1030 to 1090 MHz frequency range.

DESCRIPTION

Silicon N-channel enhancement mode lateral D-MOS transistor encapsulated in a 2-lead flangeless package (SOT538A) with a ceramic cap. The common source is connected to the mounting base.

PINNING - SOT538A

PIN DESCRIPTION						
1	drain					
2	gate					
3	source, connected to mounting base					



QUICK REFERENCE DATA

RF performance at T_h = 25 °C in a common source test circuit.

MODE OF OPERATION	f (MHz)	V _{DS} (V)	P _L (W)	G _p (dB)
Pulsed class-AB; $t_p = 50 \ \mu s; \ \delta = 2\%$	1030 to 1090	36	2	>16

ORDERING INFORMATION

TYPE NUMBER		PACKAGE	
TIPE NUMBER	NAME	DESCRIPTION	VERSION
BLA1011-2	_	ceramic surface mounted package; 2 leads	SOT538A

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	75	V
V_{GS}	gate-source voltage		_	±15	V
I _D	drain current (DC)		_	2.2	Α
P _{tot}	total power dissipation	T _h ≤ 25 °C	_	10	W
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		_	200	°C

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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
Z _{th(j-mb)}	thermal impedance from junction to mounting base	note 1	1	K/W
R _{th(mb-h)}	thermal resistance from mounting base to heatsink	note 2	6.5	K/W

Notes

- 1. Thermal impedance is determined under RF operating conditions with pulsed bias and T_h = 25 °C.
- 2. Typical value for mounting on PCB with 32 0.4 mm thermal vias with 20 μ m tin plating and thermal compound between PCB and heatsink.

CHARACTERISTICS

 $T_i = 25$ °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	$V_{GS} = 0$; $I_D = 0.2 \text{ mA}$	75	_	_	٧
V_{GSth}	gate-source threshold voltage	V _{DS} = 10 V; I _D = 20 mA	2	_	5	V
I _{DSS}	drain-source leakage current	V _{GS} = 0; V _{DS} = 26 V	_	_	0.1	mA
I _{DSX}	on-state drain current	$V_{GS} = V_{GSth} + 9 \text{ V}; V_{DS} = 10 \text{ V}$	2.8	_	_	Α
I _{GSS}	gate leakage current	$V_{GS} = \pm 15 \text{ V}; V_{DS} = 0$	_	_	40	nA
g _{fs}	forward transconductance	V _{DS} = 10 V; I _D = 0.75 A	_	0.5	_	S
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 0.75 A	_	1.2	_	Ω
C _{is}	input capacitance	V _{GS} = 0 V; V _{DS} = 26 V; f = 1 MHz	_	11	_	pF
Cos	output capacitance	V _{GS} = 0 V; V _{DS} = 26 V; f = 1 MHz	_	9	_	pF
C _{rs}	feedback capacitance	V _{GS} = 0 V; V _{DS} = 26 V; f = 1 MHz	_	0.5	_	pF

APPLICATION INFORMATION

RF performance in a common source class-AB circuit. $T_h = 25$ °C; $R_{th\ mb-h} = 6.5$ K/W unless otherwise specified.

MODE OF OPERATION	f	V _{DS}	I _{DQ}	P _L	G _p	t _r	t _f	PULSE DROOP
	(MHz)	(V)	(mA)	(W)	(dB)	(ns)	(ns)	(dB)
Pulsed class-AB; $t_p = 50 \mu s; \delta = 2\%$	1030 to 1090	36	50	2	>16	<15	<15	<0.5

Ruggedness in class-AB operation

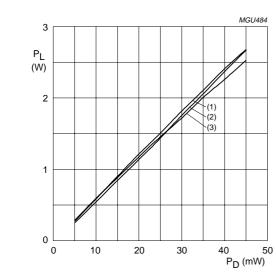
The BLA1011-2 is capable of withstanding a load mismatch corresponding to VSWR = 5 : 1 through all phases under the operating conditions.

Typical impedance values

FREQUENCY (MHz)	Z _S (Ω)	Z _L (Ω)
1030	1.51 + j 11.76	6.9 + j 5
1060	1.51 + j 11.26	6.7 + j 5.9
1090	1.52 + j 10.77	5.1 + j 6.6

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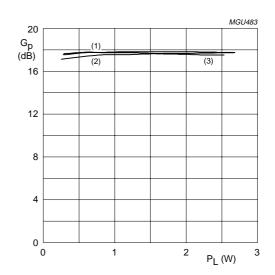


 $T_h = 25$ °C; $V_{DS} = 36$ V; $I_{DQ} = 50$ mA; class-AB;

 $t_p = 50 \ \mu s; \ \delta = 2\%.$

- (1) f = 1060 MHz.
- (2) f = 1030 MHz.
- (3) f = 1090 MHz.

Fig.2 Load power as a function of drive power; typical values.



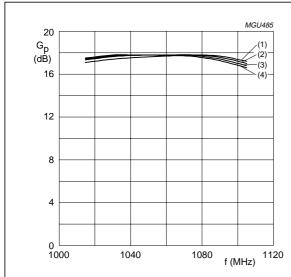
 T_h = 25 °C; V_{DS} = 36 V; I_{DQ} = 50 mA; class-AB;

 $t_p = 50 \ \mu s; \ \delta = 2\%.$ (1) f = 1060 MHz.

(2) f = 1030 MHz.

(3) f = 1090 MHz.

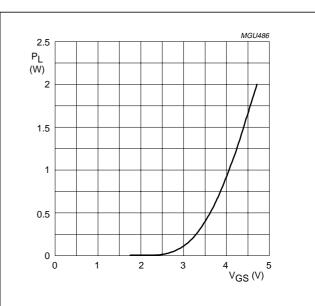
Fig.3 Power gain as a function of load power; typical values.



 T_h = 25 °C; V_{DS} = 36 V; I_{DQ} = 50 mA; class-AB; t_p = 50 $\mu s; \, \delta$ = 2%.

- (1) $P_L = 1 W$.
- (3) $P_L = 3 W$.
- (2) $P_L = 2 W$.
- (4) $P_L = 4 W$.

Fig.4 Power gain as a function of frequency; typical values.

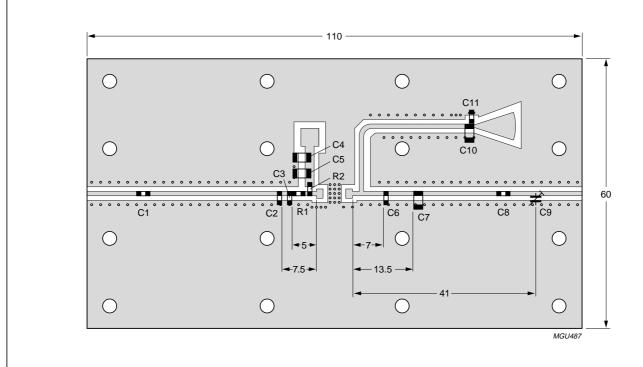


 T_h = 25 °C; V_{DS} = 36 V; I_{DQ} = 50 mA; class-AB; f = 1090 MHz; t_p = 50 $\mu s;$ δ = 2%.

Fig.5 Load power as a function of gate-source voltage; typical values.

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Dimensions in mm.

The components are situated on one side of the Rogers 6006 printed-circuit board (thickness = 0.64 mm; ϵ_r = 6.2), the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through-metallization.

Fig.6 Printed-circuit board for class-AB test circuit.

List of components for class-AB test circuit (see Fig.6)

COMPONENT	DESCRIPTION	VALUE
C1, C8	multilayer ceramic chip capacitor; note 1	56 pF
C2	multilayer ceramic chip capacitor; note 1	7.5 pF
C3	multilayer ceramic chip capacitor; note 1	1.8 pF
C4, C10	multilayer ceramic chip capacitor; note 2	20 nF
C5	multilayer ceramic chip capacitor; note 3	33 pF
C6	multilayer ceramic chip capacitor; note 1	5.6 pF
C7	multilayer ceramic chip capacitor; note 3	6.2 pF
C9	tekelec trimmer; type 37283	0.4 to 2.5 pF
C11	multilayer ceramic chip capacitor; note 1	33 pF
R1	SMD resistor	2.2 Ω (2 in parallel)
R2	SMD resistor	22 Ω

Notes

- 1. American Technical Ceramics type 100A or capacitor of same quality.
- 2. American Technical Ceramics type 200B or capacitor of same quality.
- 3. American Technical Ceramics type 100B or capacitor of same quality.

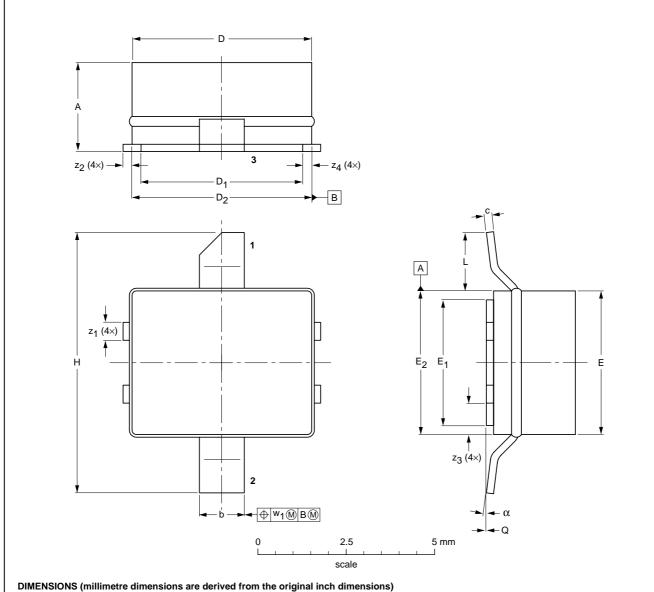
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PACKAGE OUTLINE

Ceramic surface mounted package; 2 leads

SOT538A



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UNIT	Α	b	С	D	D ₁	D ₂	E	E ₁	E ₂	Н	L	Q	w ₁	z 1	z ₂	z ₃	z ₄	α
mm	2.95 2.29	1.35 1.19	0.23 0.18	5.16 5.00	4.65 4.50	5.16 5.00	4.14 3.99	3.63 3.48	4.14 3.99	7.49 7.24	2.03 1.27	0.10 0.00	0.25	0.58 0.43	0.25 0.18	0.97 0.81	0.51 0.00	7° 0°
inches	0.116 0.090	0.053 0.047	0.009 0.007	0.203 0.197	0.183 0.177	0.203 0.197	0.163 0.157	0.143 0.137	0.163 0.157	0.295 0.285	0.080 0.050	0.004 0.000	0.010	0.023 0.017	0.010 0.007	0.038 0.032	0.020 0.000	7° 0°

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT538A						-00-03-03- 02-08-20	

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DATA SHEET STATUS

LEVEL	DATA SHEET STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾⁽³⁾	DEFINITION
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CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

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Contact information

For additional information please visit http://www.semiconductors.philips.com. Fax: +31 40 27 24825 For sales offices addresses send e-mail to: sales.addresses@www.semiconductors.philips.com.

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Printed in The Netherlands

R77/05/pp9

Date of release: 2003 Nov 19

Document order number: 9397 750 12245

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